Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/616,525	FUNK ET AL.	
Examiner	Art Unit	
J. Derek Rutten	2192	

J. Derek Rutten

	SEARCHED Subclass Date Examiner			
Class	Subclass	Date	Examiner	
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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	5/21/2007	JDR
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